

Search Notes

Application/Control No.

10/781,870

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

LIAO ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	325	6/2005	JPC
430	326		
430	327		
430	330		
430	189		
430	281.1		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH in file	6/2005	JPC
Inventor search in EAST		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner